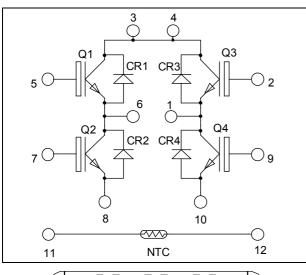
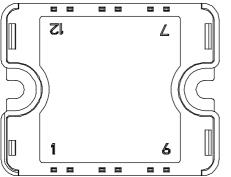


Full - Bridge Trench + Field Stop IGBT3 **Power Module**





Pins 3/4 must be shorted together

Trench + Field Stop IGBT3 Technology

- Switching frequency up to 20 kHz
- Soft recovery parallel diodes

Switched Mode Power Supplies Uninterruptible Power Supplies

Low diode VF

Welding converters

Motor control

Low leakage current

Low voltage drop

Low tail current

- RBSOA and SCSOA rated
- Very low stray inductance
- Symmetrical design
- Internal thermistor for temperature monitoring
- High level of integration

Benefits

Application

Features

- Outstanding performance at high frequency operation •
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- Each leg can be easily paralleled to achieve a phase leg of twice the current capability
- **RoHS** Compliant

Absolute maximum ratings

Symbol	Parameter		Max ratings	Unit
V _{CES}	Collector - Emitter Breakdown Voltage		600	V
т	Continuous Collector Current	$T_C = 25^{\circ}C$	80*	
1 _C	L Ontinuous Collector Current	$T_C = 80^{\circ}C$	50*	Α
I _{CM}	Pulsed Collector Current	$T_C = 25^{\circ}C$	100	
V _{GE}	Gate – Emitter Voltage		± 20	V
PD	Maximum Power Dissipation	$T_C = 25^{\circ}C$	176	W
RBSOA	Reverse Bias Safe Operating Area	$T_J = 150^{\circ}C$	100A @ 550V	

* Specification of IGBT device but output current must be limited to 40A to not exceed a delta of temperature greater than 35°C for the connectors.

🕉 🚓 UTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com

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 $V_{CES} = 600V$ $I_{C} = 50A^{*}$ @ Tc = 80°C



All ratings (a) $T_j = 25^{\circ}C$ unless otherwise specified

Electrical Characteristics

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit	
I _{CES}	Zero Gate Voltage Collector Current	$V_{GE} = 0V, V_{CE} = 600V$				250	μA
V	Collector Emitter Saturation Voltage	$V_{GE} = 15V$	$T_j = 25^{\circ}C$		1.5	1.9	V
V _{CE(sat)}		$I_C = 50A$	$T_{j} = 150^{\circ}C$		1.7		v
V _{GE(th)}	Gate Threshold Voltage	$V_{GE} = V_{CE}, I_C = 600 \mu A$		5.0	5.8	6.5	V
I _{GES}	Gate – Emitter Leakage Current	$V_{GE} = 20V, V_{CE} = 0V$				600	nA

Dynamic Characteristics

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit	
Cies	Input Capacitance	$V_{GE} = 0V$ $V_{CE} = 25V$ $f = 1MHz$			3150		
C _{oes}	Output Capacitance				200		pF
C _{res}	Reverse Transfer Capacitance				95		
T _{d(on)}	Turn-on Delay Time	Inductive Switching (25°C)			110		
T _r	Rise Time	$V_{GE} = \pm 15V$			45		ns
T _{d(off)}	Turn-off Delay Time	$V_{Bus} = 300V$ $I_C = 50A$			200		
T _f	Fall Time	$R_G = 8.2\Omega$			40		
T _{d(on)}	Turn-on Delay Time	Inductive Switching (150°C) $V_{GE} = \pm 15V$ $V_{Bus} = 300V$ $I_C = 50A$			120		
T _r	Rise Time				50		ns
T _{d(off)}	Turn-off Delay Time				250		
T _f	Fall Time	$R_G = 8.2\Omega$			60		
Eon	Turn-on Switching Energy	$V_{GE} = \pm 15V$	$T_j = 25^{\circ}C$		0.3		mJ
Lon	run-on Switching Ellergy	$V_{Bus} = 300V$	$T_{j} = 150^{\circ}C$		0.43		111J
E _{off}	Turn-off Switching Energy	$I_C = 50A$	$T_j = 25^{\circ}C$		1.35		mJ
Loff	Full of Switching Ellergy	$R_G = 8.2\Omega$	$T_{j} = 150^{\circ}C$		1.75		1115

Reverse diode ratings and characteristics

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit	
V _{RRM}	Maximum Peak Repetitive Reverse Voltage			600			V	
T	Mariana Darana Lasha a Comut	N. COON	$T_j = 25^{\circ}C$			250	۸	
I _{RM}	Maximum Reverse Leakage Current	$V_R=600V$	$T_{j} = 150^{\circ}C$			500	μA	
$I_{\rm F}$	DC Forward Current		$Tc = 80^{\circ}C$		50		А	
V _F	Diode Forward Voltage	$I_{\rm F} = 50 A$ $V_{\rm GE} = 0 V$	$T_i = 25^{\circ}C$		1.6	2	V	
• F	Diode Forward Voluge		$T_{i} = 150^{\circ}C$		1.5		•	
t _{rr}	Reverse Recovery Time		$T_j = 25^{\circ}C$		100		ns	
۹r	Reverse Recovery Time	1 504	$T_j = 150^{\circ}C$		150		115	
0	Reverse Recovery Charge	$I_F = 50A$ $V_R = 300V$ $di/dt = 1800A/\mu s$		$T_j = 25^{\circ}C$		2.6		
Q _{rr}	Reverse Recovery Charge		$T_{j} = 150^{\circ}C$		5.4		μC	
Er	Reverse Recovery Energy		$T_j = 25^{\circ}C$		0.6		mJ	
Er	Reverse Recovery Energy		$T_{j} = 150^{\circ}C$		1.2		111J	



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Thermal and package characteristics

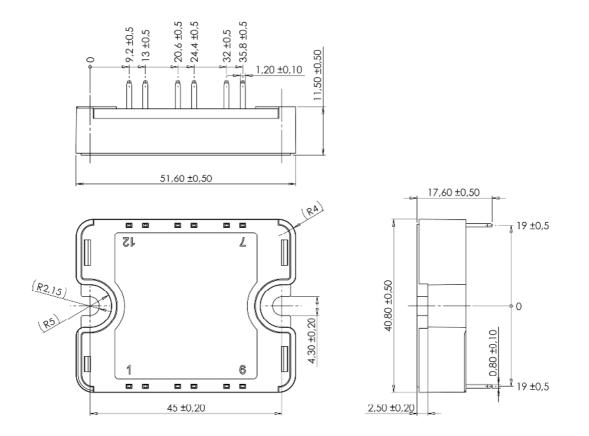
Symbol	Characteristic			Min	Тур	Max	Unit
P	lunction to Case Thermal Resistance	IGBT			0.85	°C/W	
R _{thJC}		Diode			1.42	C/ W	
V _{ISOL}	RMS Isolation Voltage, any terminal to case t =1 min, 50/60Hz			4000			V
T _J	Operating junction temperature range			-40		175	
T _{STG}	Storage Temperature Range			-40		125	°C
T _C	Operating Case Temperature -40 100						
Torque	Mounting torque	To heatsink	M4	2		3	N.m
Wt	Package Weight				80	g	

Temperature sensor NTC (see application note APT0406 on www.microsemi.com for more information).

Symbol	Characteristic	Min	Тур	Max	Unit
R ₂₅	Resistance @ 25°C		50		kΩ
B 25/85	$T_{25} = 298.15 \text{ K}$		3952		K

$$R_{T} = \frac{R_{25}}{\exp\left[B_{25/85}\left(\frac{1}{T_{25}} - \frac{1}{T}\right)\right]}$$
 T: Thermistor temperature
R_T: Thermistor value at T

SP1 Package outline (dimensions in mm)



See application note 1904 - Mounting Instructions for SP1 Power Modules on www.microsemi.com

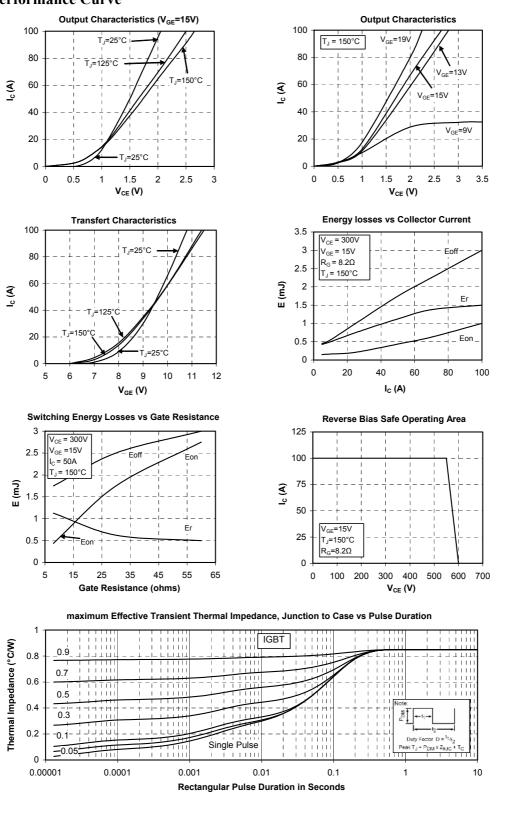
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Typical Performance Curve

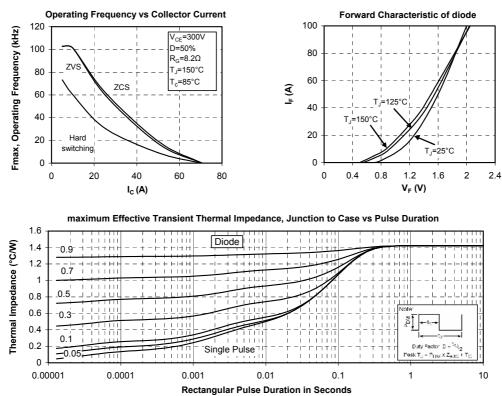
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